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APPLICATION NO.	FILI	NG DATE	FIRST NAMED INVENTOR	ATTORNEY DOCKET NO.	CONFIRMATION NO.
09/542,473	9/542,473 04/04/2000		Takayuki Ikeda	0756-2138	6069
22204	7590	09/16/2002			
NIXON PE	ABODY, I	LLP	EXAMINER		
8180 GREENSBORO DRIVE SUITE 800				SEFER, AHMED N	
MCLEAN, VA 22102			ART UNIT	PAPER NUMBER	
				2826	
			DATE MAILED: 09/16/2002		

Please find below and/or attached an Office communication concerning this application or proceeding.

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	Applicati n No.	Applicant(s)				
	09/542,473	IKEDA ET AL.				
Office Action Summary	Examiner	Art Unit				
	A. Sefer	2826				
The MAILING DATE of this communication Period f r Reply	appears on the cover shee	with the correspondence address				
A SHORTENED STATUTORY PERIOD FOR RE THE MAILING DATE OF THIS COMMUNICATIO - Extensions of time may be available under the provisions of 37 CFF after SIX (6) MONTHS from the mailing date of this communication - If the period for reply specified above is less than thirty (30) days, a - If NO period for reply is specified above, the maximum statutory per - Failure to reply within the set or extended period for reply will, by st - Any reply received by the Office later than three months after the mearned patent term adjustment. See 37 CFR 1.704(b). Status	N. R 1.136(a). In no event, however, ma . reply within the statutory minimum of riod will apply and will expire SIX (6) N atute, cause the application to becom	y a reply be timely filed thirty (30) days will be considered timely. MONTHS from the mailing date of this communication. BABANDONED (35 U.S.C. § 133).				
1) Responsive to communication(s) filed on	02 August 2002 .					
2a) ☐ This action is FINAL . 2b) ☑	This action is non-final.					
3) Since this application is in condition for all closed in accordance with the practice uno Disposition of Claims						
4)⊠ Claim(s) <u>3-10,16-33 and 35-42</u> is/are pend	ling in the application.					
4a) Of the above claim(s) is/are with	drawn from consideration.					
5) Claim(s) 3,5-7,16-21,24-33 and 35-42 is/ar	e allowed.					
6)⊠ Claim(s) <u>4,8-10,22 and 23</u> is/are rejected.						
7) Claim(s) is/are objected to.						
8) Claim(s) are subject to restriction ar Application Papers	nd/or election requirement.					
9) The specification is objected to by the Examiner.						
10)☐ The drawing(s) filed on is/are: a)☐ a	ccepted or b) objected to t	by the Examiner.				
Applicant may not request that any objection to the drawing(s) be held in abeyance. See 37 CFR 1.85(a).						
11) ☐ The proposed drawing correction filed on is: a) ☐ approved b) ☐ disapproved by the Examiner.						
If approved, corrected drawings are required in reply to this Office action.						
12)☐ The oath or declaration is objected to by the Examiner.						
Priority under 35 U.S.C. §§ 119 and 120						
13) Acknowledgment is made of a claim for foreign priority under 35 U.S.C. § 119(a)-(d) or (f).						
a) ☐ All b) ☐ Some * c) ☐ None of:						
1. Certified copies of the priority docum						
2. Certified copies of the priority docum						
 3. Copies of the certified copies of the paper of the paper of the international application from the International * See the attached detailed Office action for a 	l Bureau (PCT Rule 17.2(a)).				
14) Acknowledgment is made of a claim for dom	estic priority under 35 U.S	.C. § 119(e) (to a provisional application).				
 a) The translation of the foreign language 15) Acknowledgment is made of a claim for dom 						
Attachment(s)						
 Notice of References Cited (PTO-892) Notice of Draftsperson's Patent Drawing Review (PTO-948) Information Disclosure Statement(s) (PTO-1449) Paper No.) 5) Notice	e of Informal Patent Application (PTO-152)				

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DETAILED ACTION

Continued Examination Under 37 CFR 1.114

1. A request for continued examination under 37 CFR 1.114, including the fee set forth in 37 CFR 1.17(e), was filed in this application after final rejection. Since this application is eligible for continued examination under 37 CFR 1.114, and the fee set forth in 37 CFR 1.17(e) has been timely paid, the finality of the previous Office action has been withdrawn pursuant to 37 CFR 1.114. Applicant's submission filed on 8/2/02 has been entered.

Claim Rejections - 35 USC § 103

- 2. The following is a quotation of 35 U.S.C. 103(a) which forms the basis for all obviousness rejections set forth in this Office action:
 - (a) A patent may not be obtained though the invention is not identically disclosed or described as set forth in section 102 of this title, if the differences between the subject matter sought to be patented and the prior art are such that the subject matter as a whole would have been obvious at the time the invention was made to a person having ordinary skill in the art to which said subject matter pertains. Patentability shall not be negatived by the manner in which the invention was made.
- 3. Claims 4, 8, 9, 22 and 23 are rejected under 35 U.S.C. 103(a) as being unpatentable over Matsumoto US Patent No. 5,323,042 in view of Ikeda (JP 7-326767).

Matsumoto discloses in fig. 1 a display device comprising a pixel portion 12 and a driver portion 13 on a substrate 11, said pixel portion comprising a semiconductor film comprising a channel forming region 21a, a plurality of impurity regions 21b, a source region 21c, and a drain region 21c; and a gate electrode 25 overlapping/partially overlapping with the channel forming region and some of the impurity regions, with a

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gate insulating film 24 interposed therebetween, wherein a gate insulating film of a TFT in said driver circuit portion and a dielectric of a storage capacitor formed in said pixel portion comprise the same material and have the same film thickness.

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Ikeda discloses in figs. 1-3 a plurality of channel regions 21 and a plurality of impurity regions 31A-C having the same conductivity type as a source 23 and drain 25 regions (as in claim 23) wherein some of the impurity regions are located between the plurality of the channel regions in the semiconductor film; and a gate electrode 14 overlapping with the channel forming regions and some of the impurity regions with a gate insulating film 13 interposed therebetween.

Therefore, it would have been obvious to one skilled in the art at the time the invention was made to incorporate the teaching of Ikeda with Matsumoto's device, since that would provide a pixel with a larger numerical aperture.

As to claim 8, Ikeda discloses in fig. 3 a plurality of impurity regions 31 comprising a low concentration regions, a high concentration region, and wherein said some of the low concentration impurity regions and the high concentration impurity region are located between the plurality of the channel regions in the semiconductor film.

As to claims 9 and 22, the prior art discloses at least two impurity regions overlapped with the gate electrode and at least one impurity region overlapped with the gate electrode containing an element belonging to group XV in the periodic table (as in claim 22) but does not specifically disclose having a concentration as recited in the claim. However, it would have been obvious to optimize the device by using a workable

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range which involves only a routine skill in the art. Further, the specification contains no disclosure of either the critical nature of the claimed arrangement or any unexpected results arising therefrom. Where patentability is said to be based upon particular chosen dimensions or upon another variable recited in a claim, the applicant must show that the chosen dimensions are critical. In re Woodruff, 919 F.2d 1575, 1578, 16 USPQ2d 1934, 1936 (Fed. Cir. 1990).

4. Claims 4, 8, 10 and 23 are rejected under 35 U.S.C. 103(a) as being unpatentable over Yeo US Patent No. 6,140,162 in view of Ikeda (JP 7-326767).

Yeo discloses in fig. 3 a display device comprising a pixel portion and a driver portion on a substrate 200, said pixel portion comprising a semiconductor film comprising a channel forming region 41C, a plurality of impurity regions 41L, a source region 41S, and a drain region 41D; and a gate electrode 43G overlapping with the channel forming region, with a gate insulating film 42T interposed therebetween, wherein a gate insulating film 52 of a TFT in said driver circuit portion and a dielectric 42T of a storage capacitor formed in said pixel portion comprise the same material and have the same film thickness.

Ikeda discloses in figs. 1-3 a plurality of channel regions 21 and a plurality of impurity regions 31A-C having the same conductivity type as a source 23 and drain 25 regions (as in claim 23) wherein some of the impurity regions are located between the plurality of the channel regions in the semiconductor film; and a gate electrode 14 overlapping with the channel forming regions and some of the impurity regions with a gate insulating film 13 interposed therebetween.

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Therefore, it would have been obvious to one skilled in the art at the time the invention was made to incorporate the teaching of Ikeda with Matsumoto's device, since that would provide a pixel with a larger numerical aperture.

As to claim 8, Ikeda discloses in fig. 3 a plurality of impurity regions 31 comprising a low concentration regions, a high concentration region, and wherein said some of the low concentration impurity regions and the high concentration impurity region are located between the plurality of the channel regions in the semiconductor film.

As for claim 10, the prior art omits that electronic equipment selected from the group consisting of a video camera, a digital camera and other various electronic equipment. However, Examiner takes Official Notice that an electronic equipment comprising a display device wherein said electronic equipment selected from the group consisting of a video camera or a digital camera is conventional and well known. Therefore, it would have been obvious to one skilled in the art at the time the invention was made to have used any of the various electronic equipment since Examiner takes Official Notice that due to their low power consumption, displays have become a necessary and indispensable structural element of an electronic equipment.

Allowable Subject Matter

5. Claims 3, 5-7, 16-21, 24-33 and 35-42 are allowed.

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Conclusion

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6. The prior art made of record and not relied upon is considered pertinent to applicant's disclosure. Yamazaki US ref. 6,399,988 discloses a display device comprising electronic equipment selected from the group consisting of a video camera, a digital camera, etc.

Any inquiry concerning this communication or earlier communications from the examiner should be directed to A. Sefer whose telephone number is (703) 605-1227.

If attempts to reach the examiner by telephone are unsuccessful, the examiner's supervisor, Nathan J Flynn can be reached on (703) 308-6601.

ANS September 7, 2002

NATHAN J. FLYNN
SUPERVISORY PATENT EXAMINER
TECHNOLOGY CENTER 2800